

No. I18Z60185-SEM03

For

Q INNOVATIONS PRIVATE LIMITED

MobilePhone

Model Name: QS5509A

With

Hardware Version: 01

Software Version: 1AS1

FCC ID: 2AO6NA001

Results Summary: T Category = T4

Issued Date: 2018-6-6



Note:

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REPORT HISTORY

Report Number	Revision	Issue Date	Description	
I18Z60185-SEM03	Rev.0	2018-4-28	Initial creation of test report	
I18Z60185-SEM03	Rev.1	2018-5-28	Update Table 2.1&2.2	
I18Z60185-SEM03	Rev.2	2018-6-6	Update Air Interfaces / Bands Indicating Operating Modes	



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1 Test Laboratory

1.1 Testing Location

Company Name:	CTTL(Shouxiang)
Address:	No. 51 Shouxiang Science Building, Xueyuan Road, Haidian District,
	Beijing, P. R. China100191

1.2 Testing Environment

Temperature:	18°C~25°C,		
Relative humidity:	30%~ 70%		
Ground system resistance:	< 0.5 Ω		
Ambient poice is checked and found very low and in compliance with requirement of standards			

Ambient noise is checked and found very low and in compliance with requirement of standards. Reflection of surrounding objects is minimized and in compliance with requirement of standards.

1.3 Project Data

Project Leader:	Qi Dianyuan
Test Engineer:	Lin Hao
Testing Start Date:	April 19, 2018
Testing End Date:	April 23, 2018

1.4 Signature

Lin Xiaojun

(Prepared this test report)

Qi Dianyuan

(Reviewed this test report)

Lu Bingsong

Deputy Director of the laboratory

(Approved this test report)



2 Client Information

2.1 Applicant Information

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2.2 Manufacturer Information

Company Name:	Q INNOVATIONS PRIVATE LIMITED
Address /Post:	25, Shakuntala Farm, M G Road, Sultanpur, New Delhi-110030
Contact Person:	Mr. Gaurav Jain
E-mail:	gaurav.j@q-innovations.in
Telephone:	91-124-4648000/8111



3 Equipment Under Test (EUT) and Ancillary Equipment (AE)

3.1 About EUT

Description:	MobilePhone
Model name:	QS5509A
Operating mode(s):	WCDMA850/1700/1900 LTE B2/4/5/12/14/30/66, BT, WLAN

3.2 Internal Identification of EUT used during the test

EUT ID*	JT ID* IMEI HW Version		SW Version	
EUT1	357485090000912	01	1AS1	
EUT2	352593066935519	01	1AS1	

^{*}EUT ID: is used to identify the test sample in the lab internally.

3.3 Internal Identification of AE used during the test

AE ID	Description	Model	SN	Manufacturer
AE1 Bat		Lithium-ion		Sunwoda
	Battery	Polymer	1	Electronic
				CO.,LTD.

^{*}AE ID: is used to identify the test sample in the lab internally.

3.4 Air Interfaces / Bands Indicating Operating Modes

Air-interface	Band(MHz)	Туре	C63.19/tested	Simultaneous Transmissions	ОТТ
	850		Yes	BT, WLAN	NA
WCDMA	1700	VO			
(UMTS)	1900				
	HSPA	DT	NA		
LTE	Band 2/4/5/7/12/13/66/71	V/D	Yes	BT, WLAN	NA
BT	2450	DT	NA	WCDMA, LTE	NA
WLAN	2450	V/D	NA	WCDMA, LTE	NA

VO: Voice CMRS/PSTN Service Only V/D: Voice CMRS/PSTN and Data Service

DT: Digital Transport

^{*} HAC Rating was not based on concurrent voice and data modes, Non current mode was found to represent worst case rating for both M and T rating



4 Reference Documents

The following document listed in this section is referred for testing.

Reference	Title	Version
ANSI C63.19-2011	American National Standard for Methods of Measurement 2	
	of Compatibility between Wireless Communication Devices	Edition
	and Hearing Aids	

5 OPERATIONAL CONDITIONS DURING TEST

5.1 HAC MEASUREMENT SET-UP

These measurements are performed using the DASY5 NEO automated dosimetric assessment system. It is made by Schmid & Partner Engineering AG (SPEAG) in Zurich, Switzerland. It consists of high precision robotics system (Stäubli), robot controller, Intel Core2 computer, near-field probe, probe alignment sensor. The robot is a six-axis industrial robot performing precise movements. A cell controller system contains the power supply, robot controller, teach pendant (Joystick),and remote control, is used to drive the robot motors. The PC consists of the HP Intel Core21.86 GHz computer with Windows XP system and HAC Measurement Software DASY5 NEO, A/D interface card, monitor, mouse, and keyboard. The Stäubli Robot is connected to the cell controller to allow software manipulation of the robot. A data acquisition electronic (DAE)circuit performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. is connected to the Electro-optical coupler (EOC). The EOC performs the conversion from the optical into digital electric signal of the DAE and transfers data to the PC plug-in card.

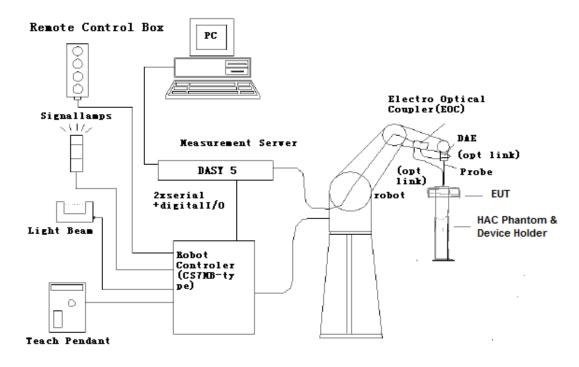
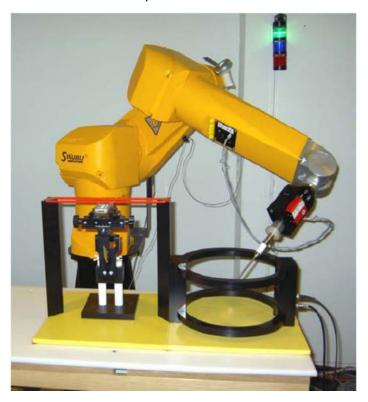


Figure 5.1 HAC Test Measurement Set-up



The DAE4 consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the PC-card is accomplished through an optical downlink for data and status information and an optical uplink for commands and clock lines. The mechanical probe mounting device includes two different sensor systems for frontal and sidewise probe contacts. They are also used for mechanical surface detection and probe collision detection. The robot uses its own controller with a built in VME-bus computer.



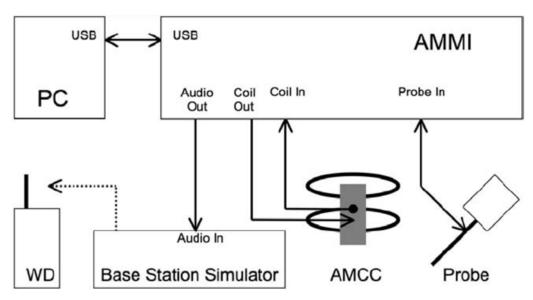


Figure 5.2 T-Coil setup with HAC Test Arch and AMCC



5.2 AM1D probe

The AM1D probe is an active probe with a single sensor. It is fully RF-shielded and has a rounded tip 6mm in diameter incorporating a pickup coil with its center offset 3mm from the tip and the sides. The symmetric signal preamplifier in the probe is fed via the shielded symmetric output cable from the AMMI with a 48V "phantom" voltage supply. The 7-pin connector on the back in the axis of the probe does not carry any signals. It is mounted to the DAE for the correct orientation of the sensor. If the probe axis is tilted 54.7 degree from the vertical, the sensor is approximately vertical when the signal connector is at the underside of the probe (cable hanging downwards).

Specification:

Frequency range	0.1~20kHz (RF sensitivity < -100dB, fully RF shielded)
Sensitivity	< -50dB A/m @ 1kHz
Pre-amplifier	40dB, symmetric
Dimensions	Tip diameter/length: 6/290mm, sensor according to ANSI-C63.19

5.3 AMCC

The Audio Magnetic Calibration coil is a Helmholtz Coil designed for calibration of the AM1D probe. The two horizontal coils generate a homogeneous magnetic field in the z direction. The DC input resistance is adjusted by a series resistor to approximately 500hm, and a shunt resistor of 100hm permits monitoring the current with a scale of 1:10

Port description:

Signal	Connector	Resistance
Coil In	BNC	Typically 500hm
Coil Monitor	BNO	10Ohm±1% (100mV corresponding to 1 A/m)

Specification:

Dimensions	370 x 370 x 196 mm, according to ANSI-C63.19
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5.4 AMMI



Figure 5.3 AMMI front panel

The Audio Magnetic Measuring Instrument (AMMI) is a desktop 19-inch unit containing a sampling unit, a waveform generator for test and calibration signals, and a USB interface.

Specification:

Sampling rate	48 kHz / 24 bit
Dynamic range	85 dB
Test signal generation	User selectable and predefined (vis PC)
Calibration	Auto-calibration / full system calibration using AMCC with monitor output
Dimensions	482 x 65 x 270 mm



5.5 Test Arch Phantom & Phone Positioner

The Test Arch phantom should be positioned horizontally on a stable surface. Reference markings on the Phantom allow the complete setup of all predefined phantom positions and measurement grids by manually teaching three points in the robot. It enables easy and well defined positioning of the phone and validation dipoles as well as simple teaching of the robot (Dimensions: $370 \times 370 \times 370 \text{ mm}$).

The Phone Positioner supports accurate and reliable positioning of any phone with effect on near field $<\pm 0.5$ dB.

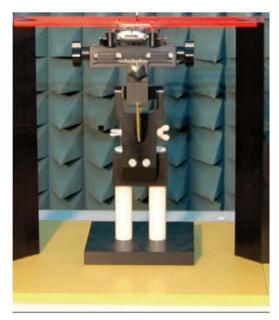


Figure 5.4 HAC Phantom & Device Holder

5.6 Robotic System Specifications

Specifications

Positioner: Stäubli Unimation Corp. Robot Model: RX160L

Repeatability: ±0.02 mm

No. of Axis: 6

Data Acquisition Electronic (DAE) System

Cell Controller

Processor:Intel Core2
Clock Speed: 1.86GHz

Operating System: Windows XP

Data Converter

Features: Signal Amplifier, multiplexer, A/D converter, and control logic

Software: DASY5 software

Connecting Lines: Optical downlink for data and status info.

Optical uplink for commands and clock



5.7 T-Coil measurement points and reference plane

Figure 6.5 illustrates the standard probe orientations. Position 1 is the perpendicular orientation of the probe coil; orientation 2 is the transverse orientations. The space between the measurement positions is not fixed. It is recommended that a scan of the WD be done for each probe coil orientation and that the maximum level recorded be used as the reading for that orientation of the probe coil.

- 1) The reference plane is the planar area that contains the highest point in the area of the phone that normally rests against the user's ear. It is parallel to the centerline of the receiver area of the phone and is defined by the points of the receiver-end of the WD handset, which, in normal handset use, rest against the ear.
- 2) The measurement plane is parallel to, and 10 mm in front of, the reference plane.
- 3) The reference axis is normal to the reference plane and passes through the center of the receiver speaker section (or the center of the hole array); or may be centered on a secondary inductive source. The actual location of the measurement point shall be noted in the test report as the measurement reference point.
- 4) The measurement points may be located where the axial and radial field intensity measurements are optimum with regard to the requirements. However, the measurement points should be near the acoustic output of the WD and shall be located in the same half of the phone as the WD receiver. In a WD handset with a centered receiver and a circularly symmetrical magnetic field, the measurement axis and the reference axis would coincide.
- 5) The relative spacing of each measurement orientation is not fixed. The axial and two radial orientations should be chosen to select the optimal position.
- 6) The measurement point for the axial position is located 10 mm from the reference plane on the measurement axis. The actual location of the measurement point shall be noted in test reports and designated as the measurement reference point.

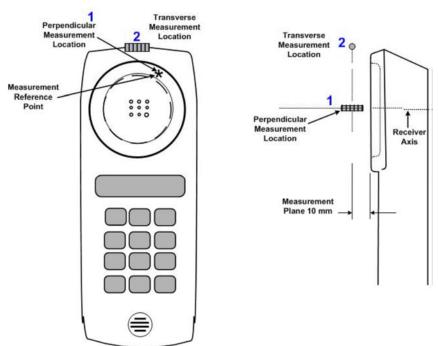


Figure 5.5 Axis and planes for WD audio frequency magnetic field measurements



6 T-Coil TEST PROCEDUERES

The following illustrate a typical test scan over a wireless communications device:

- 1) Geometry and signal check: system probe alignment, proper operation of the field probe, probe measurement system, other instrumentation, and the positioning system was confirmed. A surface calibration was performed before each setup change to ensure repeatable spacing and proper maintenance of the measurement plane using the test Arch.
- 2) Set the reference drive level of signal voice defined in C63.19 per 7.4.2.1.
- 3) The ambient and test system background noise (dB A/m) was measured as well as ABM2 over the full measurement. The maximum noise level must be at least 10dB below the limit.
- 4) The DUT was positioned in its intended test position, acoustic output point of the device perpendicular to the field probe.
- 5) The DUT operation for maximum rated RF output power was configured and connected by using of coaxial cable connection to the base station simulator at the test channel and other normal operating parameters as intended for the test. The battery was ensured to be fully charged before each test. The center sub-grid was centered over the center of the acoustic output (also audio band magnetic output, if applicable). The DUT audio output was positioned tangent (as physically possible) to the measurement plane.
- 6) The DUT's RF emission field was eliminated from T-coil results by using a well RF-shielding of the probe, AM1D, and by using of coaxial cable connection to a Base Station Simulator. One test channel was pre-measurement to avoid this possibility.
- 7) Determined the optimal measurement locations for the DUT by following the three steps, coarse resolution scan, fine resolution scans, and point measurement, as described in C63.19 per 7.4.4.2. At each measurement locations, samples in the measurement window duration were evaluated to get ABM1 and the signal spectrum. The noise measurement was performed after the scan with the signal, the same happened, just with the voice signal switched off. The ABM2 was calculated from this second scan.
- 8) All results resulting from a measurement point in a T-Coil job were calculated from the signal samples during this window interval. ABM values were averaged over the sequence of there samples.
- 9) At an optimal point measurement, the SNR (ABM1/ABM2) was calculated for perpendicular and transverse orientation, and the frequency response was measured for perpendicular.
- 10) Corrected for the frequency response after the DUT measurement since the DASY5 system had known the spectrum of the input signal by using a reference job.
- 11) In SEMCAD postprocessing, the spectral points are in addition scaled with the high-pass (half-band) and the A-weighting, bandwidth compensated factor (BWC) and those results are final as shown in this report.



7 T-Coil PERFORMANCE REQUIREMENTS

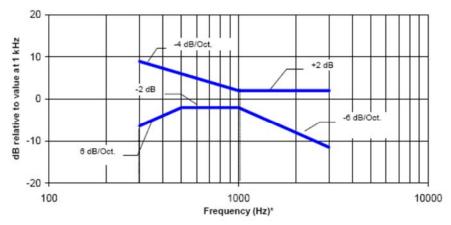
In order to be rated for T-Coil use, a WD shall meet the requirements for signal level and signal quality contained in this part.

7.1 T-Coil coupling field intensity

When measured as specified in ANSI C63.19, the T-Coil signal shall be ≥ -18 dB (A/m) at 1 kHz, ina1/3 octave band filter for all orientations.

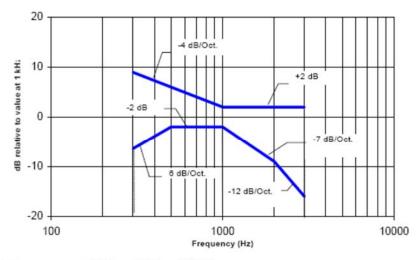
7.2 Frequency response

The frequency response of the axial component of the magnetic field, measured in 1/3 octave bands, shall follow the response curve specified in this sub-clause, over the frequency range 300 Hz to 3000 Hz. Figure 7.1 and Figure 7.2 provide the boundaries for the specified frequency. These response curves are for true field strength measurements of the T-Coil signal. Thus the 6 dB/octave probe response has been corrected from the raw readings.



NOTE-Frequency response is between 300 Hz and 3000 Hz.

Figure 7.1—Magnetic field frequency response for WDs with a field ≤ −15 dB (A/m) at 1 kHz



NOTE—Frequency response is between 300 Hz and 3000 Hz.

Figure 7.2—Magnetic field frequency response for WDs with a fieldthat exceeds –15 dB(A/m) at 1 kHz



7.3 Signal quality

This part provides the signal quality requirement for the intended T-Coil signal from a WD. Only the RF immunity of the hearing aid is measured in T-Coil mode. It is assumed that a hearing aid can have noimmunity to an interference signal in the audio band, which is the intended reception band for this mode. So, the only criteria that can be measured is the RF immunity in T-Coil mode. This is measured using the same procedure as for the audio coupling mode and at the same levels. The worst signal quality of the three T-Coil signal measurements shall be used to determine the T-Coil mode category per Table 1

Table 1:T-Coil signal quality categories

- rame in contragance						
Category	Telephone parameters					
	WD signal quality					
	[(signal + noise) - to - noise ratio in decibels]					
Category T1	0 dB to 10 dB					
Category T2	10 dB to 20 dB					
Category T3	20 dB to 30 dB					
Category T4	> 30 dB					



8 VOLTE TEST SYSTEM SETUP AND DUT CONFIGURATION

8.1 Test System Setup for VoLTE over IMS T-coil Testing

The general test setup used for VoLTE over IMS is shown below. The callbox used when performing VoLTE over IMS T-coil measurements is a CMW500. The Data Application Unit (DAU) of the CMW500 was used to simulate the IP Multimedia Subsystem (IMS) server.

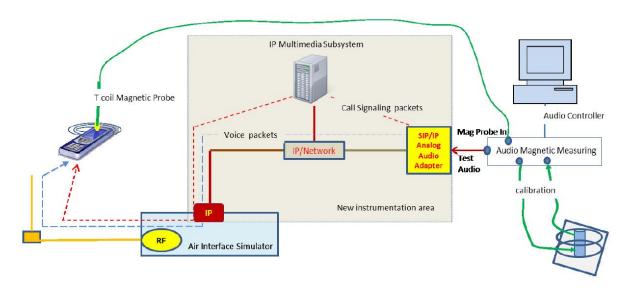


Figure 8.1 Test Setup for VoLTE over IMS T-coil Measurements

8.2 Codec Configuration

An investigation was performed to determine the audio codec configuration to be used for testing. The EVS Primary NB 13.2kbps setting was used for the audio codec on the CMW500 for VoLTE over IMS T-coil testing. See below table for comparisons between different codecs and codec data rates:

Codec **WB AMR WB AMR NB AMR NB AMR** Orientation Band/BW Channel Setting 23.85kbps 6.60kbps 12.2kbps 4.75kbps ABM1 3.95 -2.92 -3.05 4.07 (dBA/m) Frequency **PASS PASS PASS PASS** Z(axial) B2/20M 18900 Response SNR (dB) 53.12 46.59 45.77 52.89

Table 8-1 AMR Codec Investigation – VoLTE over IMS

Table 8-2 EVS Codec Investigation – VoLTE over IMS

	EVS	EVS	EVS	EVS	EVS	EVS			
Codec	Primary	Primary	Primary	Primary	Primary	Primary	Orientatio	Dond	Channa
	SWB	SWB	WB	WB	NB	NB		Band	Channe
Setting	13.2kbp	9.6kbp	13.2kbp	5.9kbp	13.2kbp	5.9kbp	n	/BW	1
	s	s	s	s	s	s			
ABM1	4.16	4.10	4.15	4.37	4.68	4.49	7/oviol\	B2/20	10000
(dBA/m)	4.10	4.10	4.15	4.37	4.00	4.49	Z(axial)	М	18900



Frequenc								
у	PASS	PASS	PASS	PASS	PASS	PASS		
Response								
SNR (dB)	52.83	52.71	52.30	52.32	54.24	54.09		

8.3 Radio Configuration

An investigation was performed to determine the modulation and RB configuration to be used for testing. 16QAM, 1RB, 0RB offset was used for the testing as the worst-case configuration for the handset. See below table for comparisons between different radio configurations:

Table 8-3 VoLTE over IMS SNR by Radio Configuration

Frequency	Channel	Bandwidth	Modulation	RB Size	RB Offset	ABM1	SNR
[MHz]		[MHz]				[dB(A/m)]	[dB]
1880	18900	20	QPSK	1	0	4.61	54.76
1880	18900	20	QPSK	1	50	<mark>-3.05</mark>	<mark>45.77</mark>
1880	18900	20	QPSK	1	99	4.61	55.06
1880	18900	20	QPSK	50	0	4.58	55.48
1880	18900	20	QPSK	50	25	4.61	55.41
1880	18900	20	QPSK	50	50	4.09	53.83
1880	18900	20	QPSK	100	0	4.04	53.45
1880	18900	20	16QAM	1	0	4.50	54.74
1880	18900	20	16QAM	1	50	4.53	54.61
1880	18900	20	16QAM	1	99	4.60	55.30
1880	18900	20	16QAM	50	0	4.57	55.50
1880	18900	20	16QAM	50	25	4.11	53.86
1880	18900	20	16QAM	50	50	4.04	53.30
1880	18900	20	16QAM	100	0	4.05	53.35



9 HAC T-Coil TEST DATA SUMMARY

9.1 Test Results for 2/3G

Probe Position	Band	Ch.	Measurement Position (x mm, y mm)	ABM1 (dB A/m)	SNR (dB)	T category
	WCDMA850	4407	2.5, -8.3	-9.60	43.72	T4
transverse	WCDMA1900	9800	2.5, -8.3	-9.52	44.05	T4
	WCDMA1700	1637	1.7, -8.3	-9.52	44.38	T4
perpendicular	WCDMA850	4407	2.9, 0	-1.35	50.63	T4
	WCDMA1900	9800	2.5, 0	-1.26	50.75	T4
	WCDMA1700	1637	2.5, 0	-1.16	51.45	T4

Note:

- 1. Bluetooth and WiFi function is turn off and microphone is muted.
- 2. Signal strength measurement scan plots are presented in Annex B.
- 3. The volume is adjusted to maximum level during T-Coil testing.

9.2 Test Results for LTE

Probe Position	Band	Ch.	Bandwidth	Measurement Position (x mm, y mm)	ABM1 (dB A/m)	SNR (dB)	Category T?
			1.4M	1.3, 8.3	-4.73	47.33	T4
			3M	3.8, -8.8	-4.22	48.70	T4
	LTE B2	18900	5M	3.8, -9.2	-4.30	49.10	T4
	LIEBZ	10900	10M	3.3, -8.8	-4.32	49.15	T4
			15M	3.3, -8.3	-4.42	48.73	T4
			20M	3.3, -8.8	-4.27	48.91	T4
			1.4M	1.7,7.5	-4.94	47.85	T4
	LTE B5	20525	3M	0.8, 8.3	-5.05	47.87	T4
			5M	1.3, 8.3	-5.08	47.93	T4
Transverse			10M	0.8, 7.9	-5.17	47.74	T4
	LTE B12		1.4M	0.8, 8.3	-4.72	48.06	T4
У		23095	3M	2.9, -8.8	-4.07	48.70	T4
		23093	5M	3.8, -8.8	-4.26	50.38	T4
			10M	2.9, -8.3	-4.31	49.99	T4
	LTE B14	23330	5M	3.3, -8.3	-4.09	49.29	T4
	LIE DI4	23330	10M	2.9, -8.8	-4.05	48.81	T4
			1.4M	2.1, -8.8	-4.29	50.21	T4
			3M	0.8, 8.3	-5.05	48.34	T4
	LTE B66	132322	5M	1.3, 7.9	-4.80	48.74	T4
			10M	1.3, 8.3	-4.72	48.52	T4
			15M	0.8, 8.3	-4.92	48.30	T4



		1				1	
			20M	2.9, -9.2	-4.13	49.67	T4
	LTE B30	27710	5M	2.9, -8.8	-4.05	49.17	T4
	LIE B30	27710	10M	2.9, -8.8	-4.08	49.17	T4
			1.4M	1.3,-0.4	3.12	52.29	T4
			3M	4.2, -0.4	3.83	53.85	T4
	LTE B2	18900	5M	3.8, -1.7	3.80	54.07	T4
	LIE BZ	10900	10M	3.8, -0.4	3.84	54.22	T4
			15M	8.3, -0.4	0.90	51.63	T4
			20M	1.7, -1.7	-3.05	45.77	T4
			1.4M	1.7, -0.4	3.18	53.27	T4
	I TE DE	20525	3M	1.3, -0.4	3.15	53.61	T4
	LTE B5	20020	5M	1.7, -0.4	3.07	53.33	T4
			10M	1.3, -0.8	3.16	53.01	T4
	LTE B12	23095	1.4M	0.4, -0.4	3.37	53.64	T4
Perpendicular			3M	3.8, -0.4	-2.64	48.24	T4
z			5M	4.2, -0.4	3.91	55.48	T4
			10M	3.3, -0.8	3.88	55.57	T4
	LTE B14	23330	5M	3.3, 0	4.16	54.72	T4
	LIE DI4		10M	3.3, -0.4	4.20	54.60	T4
			1.4M	0.8, -0.4	3.02	53.60	T4
			3M	0.8, -0.4	3.09	53.84	T4
	LTE B66	132322	5M	0.8, -0.8	3.25	53.85	T4
	LIE DOO	132322	10M	0.8, -0.4	3.36	53.91	T4
			15M	1.3, -0.4	3.54	53.65	T4
			20M	3.3, -1.7	4.15	54.61	T4
	LTE B30	27710	5M	3.3, -0.4	4.17	54.33	T4
	LIE DOU	21110	10M	3.8, -0.4	4.28	54.52	T4

Note:

- 1. Bluetooth and WiFi function is turn off and microphone is muted.
- 2. The worse case of each band for signal strength measurement scan plots are presented in Annex B.
- 3. The volume is adjusted to maximum level during T-Coil testing.



9.4 Total Measurement Conclusion

Probe Position	Frequency Band(MHz)	ABM1	Frequency Response	T Category
	WCDMA850	Pass		T4
	WCDMA1900	Pass	/	T4
	WCDMA1700	Pass		T4
	LTE B2	Pass	Pass	T4
Transverse	LTE B5	Pass	Pass	T4
	LTE B12	Pass	Pass	T4
	LTE B14	Pass	Pass	T4
	LTE B30	Pass	Pass	T4
	LTE B66	Pass	Pass	T4
	WCDMA850	Pass	Pass	T4
	WCDMA1900	Pass	Pass	T4
	WCDMA1700	Pass	Pass	T4
	LTE B2	Pass	Pass	T4
Perpendicular	LTE B5	Pass	Pass	T4
	LTE B12	Pass	Pass	T4
	LTE B14	Pass	Pass	T4
	LTE B30	Pass	Pass	T4
	LTE B66	Pass	Pass	T4



10 MEASUREMENT UNCERTAINTY

No.	Error source	Туре	Uncertainty Value	Prob. Dist.	Div.	ABM1	ABM2	Std. Unc.	Std. Unc.
								ABM1 u_i	ABM2 u_i
								(%)	(%)
1	System Repeatability	A	0.016	N	1	1	1	0.016	0.016
Probe Sensitivity									I
2	Reference Level	В	3.0	R	$\sqrt{3}$	1	1	3.0	3.0
3	AMCC Geometry	В	0.4	R	$\sqrt{3}$	1	1	0.2	0.2
4	AMCC Current	В	0.6	R	$\sqrt{3}$	1	1	0.4	0.4
5	Probe Positioning during Calibration	В	0.1	R	$\sqrt{3}$	1	1	0.1	0. 1
6	Noise Contribution	В	0.7	R	$\sqrt{3}$	0.014	1	0.0	0.4
7	Frequency Slope	В	5. 9	R	$\sqrt{3}$	0.1	1	0.3	3. 5
Prob	e System		•		•			•	
8	Repeatability / Drift	В	1.0	R	$\sqrt{3}$	1	1	0.6	0.6
9	Linearity / DynamicRange	В	0.6	N	1	1	1	0.4	0.4
10	Acoustic Noise	В	1.0	R	$\sqrt{3}$	0.1	1	0.1	0.6
11	Probe Angle	В	2.3	R	$\sqrt{3}$	1	1	1.4	1.4
12	Spectral Processing	В	0.9	R	$\sqrt{3}$	1	1	0.5	0.5
13	Integration Time	В	0.6	N	1	1	5	0.6	3.0
14	Field Distribution	В	0.2	R	$\sqrt{3}$	1	1	0.1	0. 1
Test	Test Signal								
15	Ref.Signal Spectral Response	В	0.6	R	$\sqrt{3}$	0	1	0.0	0.4
Posit	Positioning								
16	Probe Positioning	В	1.9	R	$\sqrt{3}$	1	1	1.1	1. 1
17	Phantom Thickness	В	0.9	R	$\sqrt{3}$	1	1	0.5	0.5



18	DUT Positioning	В	1.9	R	$\sqrt{3}$	1	1	1.1	1.1
External Contributions									
19	RF Interference	В	0.0	R	$\sqrt{3}$	1	0.3	0.0	0.0
20	Test Signal Variation	В	2.0	R	$\sqrt{3}$	1	1	1.2	1.2
	pined Std. Uncertainty	$u_c' = \sqrt{\sum_{i=1}^{20} c_i^2 u_i^2}$						4. 1	6. 1
Expanded Std. Uncertainty		$u_e = 2u_c$		N	<i>k</i> = 2		8. 2	12. 2	

11 MAIN TEST INSTRUMENTS

List of Main Instruments

No.	Name	Туре	Serial Number	Calibration Date	Valid Period
01	Audio Magnetic 1D Field Probe	AM1DV2	1064	July 20, 2017	NCR
02	Audio Magnetic Calibration Coil	AMCC	ICC 1064 NCR		NCR
03	Audio Measuring Instrument	AMMI 1044		NCR	NCR
04	HAC Test Arch	N/A	1014	NCR	NCR
05	DAE	DAE4	777	September 8, 2017	One year
06	Software	DASY5 V5.0 Build 119.9	N/A	NCR	NCR
07	Software	SEMCAD V13.2 Build 87	N/A	NCR	NCR
08	Universal Radio Communication Tester	CMU 200	105948	October 31, 2017	One year
09	Universal Radio Communication Tester	CMW 500	164049	September 12, 2017	One year

END OF REPORT BODY



ANNEX A TEST LAYOUT



Picture A1: HAC T-Coil System Layout



ANNEX B TEST PLOTS

T-Coil WCDMA 850 Transverse

Date: 2018-4-19

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.5°C

Communication System: WCDMA 850; Frequency: 836.4 MHz; Duty Cycle: 1:1

Probe: AM1DV2 - 1064;

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50/ABM Interpolated Signal(x,y,z)

(121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 37.15

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1 = -9.58 dBA/m BWC Factor = 0.16 dB Location: 2.9, -8.3, 3.7 mm

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50/ABM Interpolated SNR(x,y,z)

(121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 37.15

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

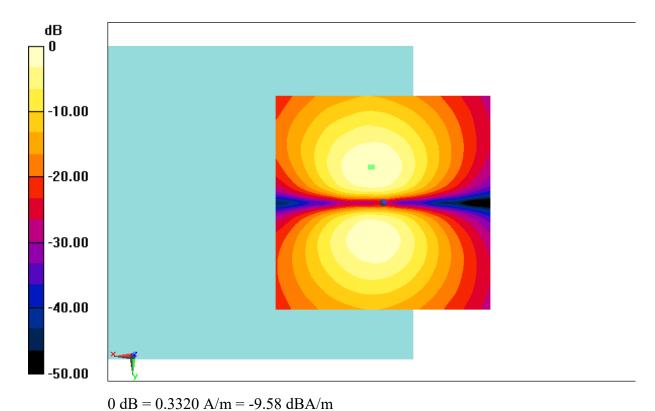
Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1/ABM2 = 43.72 dB ABM1 comp = -9.60 dBA/m BWC Factor = 0.16 dB

Location: 2.5, -8.3, 3.7 mm





7 db 0.5520 7 mm 7.50 db/ 4 m

Fig B.1 T-Coil WCDMA 850



T-Coil WCDMA 850 Perpendicular

Date: 2018-4-19

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.5°C

Communication System: WCDMA 850; Frequency: 836.4 MHz; Duty Cycle: 1:1

Probe: AM1DV2 - 1064;

T-Coil/General Scans/z (axial) 4.2mm 50 x 50/ABM Interpolated Signal(x,y,z)

(121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 37.15

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1 = -1.35 dBA/m BWC Factor = 0.16 dB Location: 2.9, 0, 3.7 mm

T-Coil/General Scans/z (axial) 4.2mm 50 x 50/ABM Interpolated SNR(x,y,z) (121x121x1):

Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 37.15

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1/ABM2 = 50.63 dB ABM1 comp = -1.35 dBA/m BWC Factor = 0.16 dB

Location: 2.9, 0, 3.7 mm



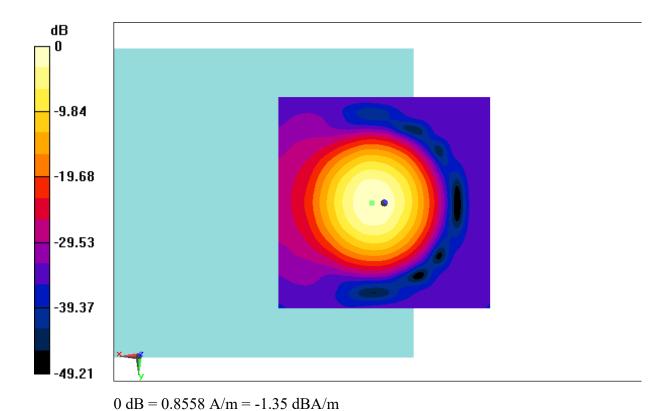


Fig B.2 T-Coil WCDMA 850



T-Coil WCDMA 1900 Transverse

Date: 2018-4-19

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.5°C

Communication System: WCDMA 1900; Frequency: 1880 MHz; Duty Cycle: 1:1

Probe: AM1DV2 - 1064;

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50/ABM Interpolated

Signal(x,y,z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 37.15

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1 = -9.51 dBA/m BWC Factor = 0.16 dB Location: 2.9, -8.3, 3.7 mm

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50/ABM Interpolated

SNR(x,y,z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 37.15

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1/ABM2 = 44.05 dB

ABM1 comp = -9.52 dBA/m

BWC Factor = 0.16 dB

Location: 2.5, -8.3, 3.7 mm



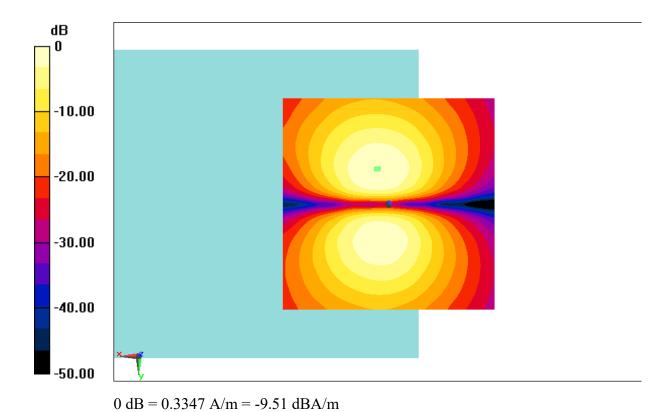


Fig B.3 T-Coil WCDMA 1900



T-Coil WCDMA 1900 Perpendicular

Date: 2018-4-19

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.5°C

Communication System: WCDMA 1900; Frequency: 1880 MHz; Duty Cycle: 1:1

Probe: AM1DV2 - 1064;

T-Coil/General Scans/z (axial) 4.2mm 50 x 50/ABM Interpolated Signal(x,y,z)

(121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav

Output Gain: 37.15

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1 = -1.24 dBA/m BWC Factor = 0.16 dB Location: 2.9, 0, 3.7 mm

T-Coil/General Scans/z (axial) 4.2mm 50 x 50/ABM Interpolated SNR(x,y,z)

(121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 37.15

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1/ABM2 = 50.75 dB ABM1 comp = -1.26 dBA/m BWC Factor = 0.16 dB

Location: 2.5, 0, 3.7 mm



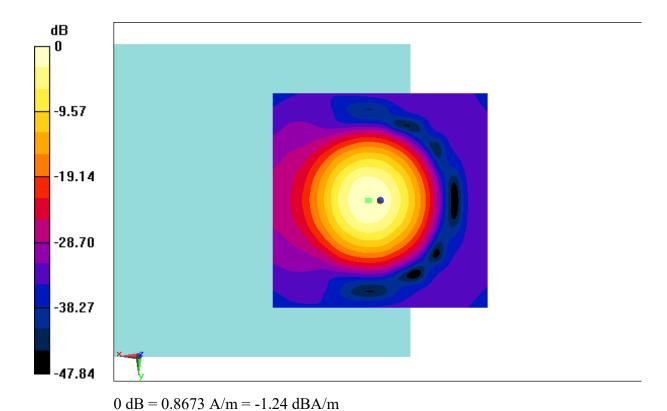


Fig B.4 T-Coil WCDMA 1900



T-Coil WCDMA 1700 Transverse

Date: 2018-4-20

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.5°C

Communication System: WCDMA 1700; Frequency: 1732.4 MHz; Duty Cycle: 1:1

Probe: AM1DV2 - 1064;

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50/ABM Interpolated Signal(x,y,z)

(121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 37.15

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1 = -9.40 dBA/m BWC Factor = 0.16 dB Location: 2.9, -8.3, 3.7 mm

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50/ABM Interpolated SNR(x,y,z)

(121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 37.15

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

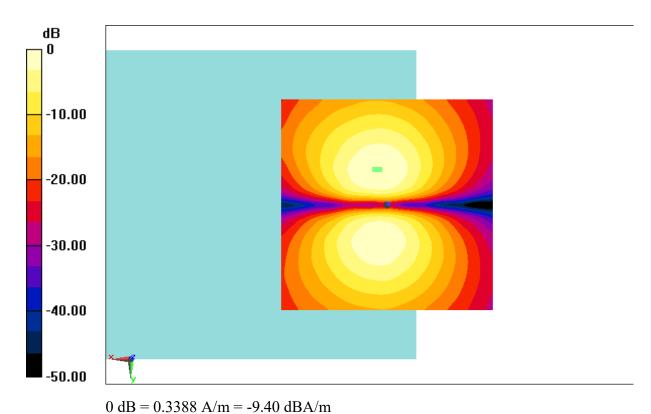
Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1/ABM2 = 44.38 dB ABM1 comp = -9.52 dBA/m BWC Factor = 0.16 dB

Location: 1.7, -8.3, 3.7 mm





0 dD = 0.3388 A/III = -9.40 dDA/III

Fig B.5 T-Coil WCDMA 1700



T-Coil WCDMA 1700 Perpendicular

Date: 2018-4-20

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.5°C

Communication System: WCDMA 1700; Frequency: 1732.4 MHz; Duty Cycle: 1:1

Probe: AM1DV2 - 1064;

T-Coil/General Scans/z (axial) 4.2mm 50 x 50/ABM Interpolated Signal(x,y,z)

(121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 37.15

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1 = -1.14 dBA/m BWC Factor = 0.16 dB Location: 2.9, 0, 3.7 mm

T-Coil/General Scans/z (axial) 4.2mm 50 x 50/ABM Interpolated SNR(x,y,z) (121x121x1):

Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 37.15

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1/ABM2 = 51.45 dB ABM1 comp = -1.16 dBA/m BWC Factor = 0.16 dB

Location: 2.5, 0, 3.7 mm



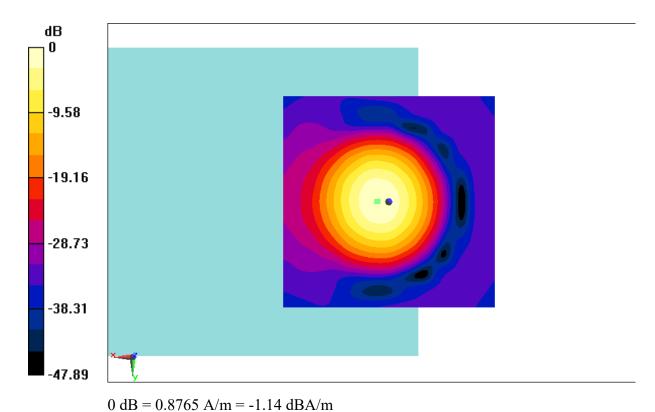


Fig B.6 T-Coil WCDMA 1700



T-Coil LTE B2 1.4M Transverse

Date: 2018-4-20

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.5°C

Communication System: LTE B2; Frequency: 1880 MHz; Duty Cycle: 1:1

Probe: AM1DV2 - 1064;

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50 1.4M/ABM Interpolated

Signal(x,y,z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1 = -4.34 dBA/m BWC Factor = 0.16 dB Location: 3.3, -8.8, 3.7 mm

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50 1.4M/ABM Interpolated

SNR(x,y,z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

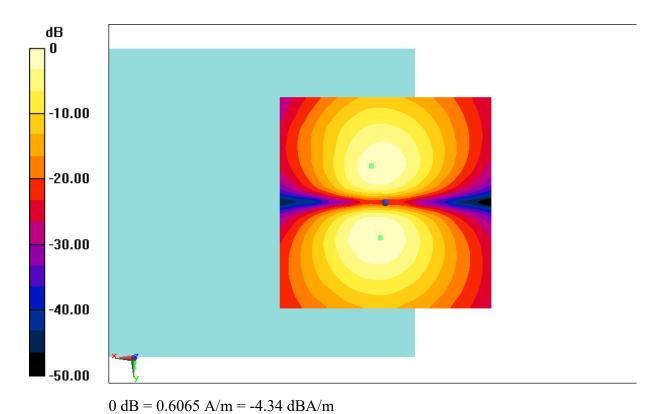
Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1/ABM2 = 47.44 dBABM1 comp = -4.73 dBA/m

BWC Factor = 0.16 dB Location: 1.3, 8.3, 3.7 mm





db 0.0003 10 m +.5+ db/0 m

Fig B.7 T-Coil LTE B2



T-Coil LTE B2 1.4M Perpendicular

Date: 2018-4-20

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.5°C

Communication System: LTE B2; Frequency: 1880 MHz; Duty Cycle: 1:1

Probe: AM1DV2 - 1064;

T-Coil/General Scans/z (axial) 4.2mm 50 x 50 1.4M/ABM Interpolated Signal(x,y,z)

(121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1 = 3.48 dBA/m BWC Factor = 0.16 dB Location: 3.3, -0.4, 3.7 mm

T-Coil/General Scans/z (axial) 4.2mm 50 x 50 1.4M/ABM Interpolated SNR(x,y,z)

(121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1/ABM2 = 52.29 dB ABM1 comp = 3.12 dBA/m BWC Factor = 0.16 dB Location: 1.3, -0.4, 3.7 mm



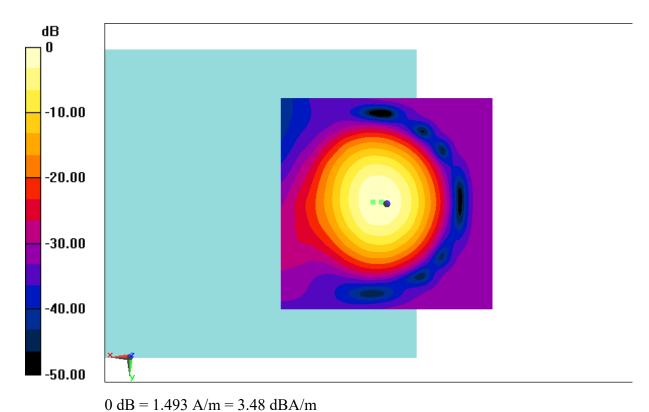


Fig B.8 T-Coil LTE B2



T-Coil LTE B2 20M Transverse

Date: 2018-4-20

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.5°C

Communication System: LTE B2; Frequency: 1880 MHz; Duty Cycle: 1:1

Probe: AM1DV2 - 1064;

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50/ABM Interpolated

Signal(x,y,z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1 = -4.25 dBA/m BWC Factor = 0.16 dB Location: 3.8, -8.8, 3.7 mm

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50/ABM Interpolated

SNR(x,y,z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

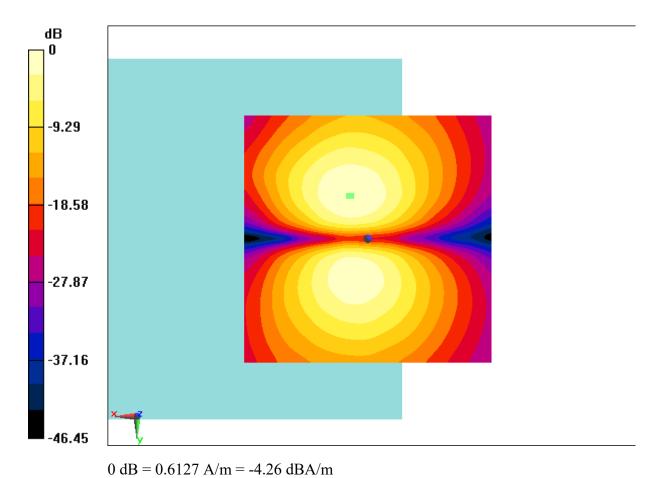
ABM1/ABM2 = 48.91 dB

ABM1 comp = -4.27 dBA/m

BWC Factor = 0.16 dB

Location: 3.3, -8.8, 3.7 mm





42 0.012 / 12 m 1.20 43 12 m

Fig B.9 T-Coil LTE B2



T-Coil LTE B2 20M Perpendicular

Date: 2018-4-20

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.5°C

Communication System: LTE B2; Frequency: 1880 MHz; Duty Cycle: 1:1

Probe: AM1DV2 - 1064;

T-Coil/General Scans 1RB_MIddle(QPSK)/z (axial) 4.2mm 50 x 50 NB12.2/ABM Interpolated Signal(x,y,z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1 = -2.72 dBA/m BWC Factor = 0.16 dB Location: 3.3, -1.7, 3.7 mm

T-Coil/General Scans 1RB_MIddle(QPSK)/z (axial) 4.2mm 50 x 50 NB12.2/ABM Interpolated SNR(x,y,z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1/ABM2 = 45.77 dB ABM1 comp = -3.05 dBA/m BWC Factor = 0.16 dB

Location: 1.7, -1.7, 3.7 mm



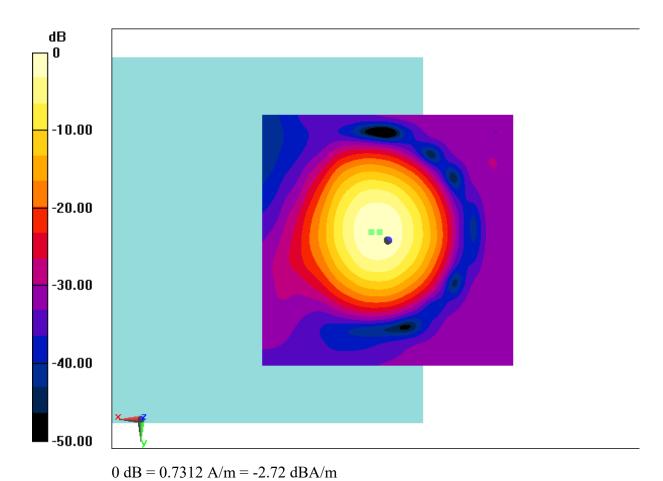


Fig B.10 T-Coil LTE B2



T-Coil LTE B5 10M Transverse

Date: 2018-4-21

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.5°C

Communication System: LTE B5; Frequency: 836.5 MHz; Duty Cycle: 1:1

Probe: AM1DV2 - 1064;

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50 10M/ABM Interpolated Signal(x,y,z)

(121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1 = -4.60 dBA/m BWC Factor = 0.16 dB Location: 3.3, -8.8, 3.7 mm

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50 10M/ABM Interpolated SNR(x,y,z)

(121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1/ABM2 = 47.74 dB ABM1 comp = -5.17 dBA/mBWC Factor = 0.16 dB

Location: 0.8, 7.9, 3.7 mm



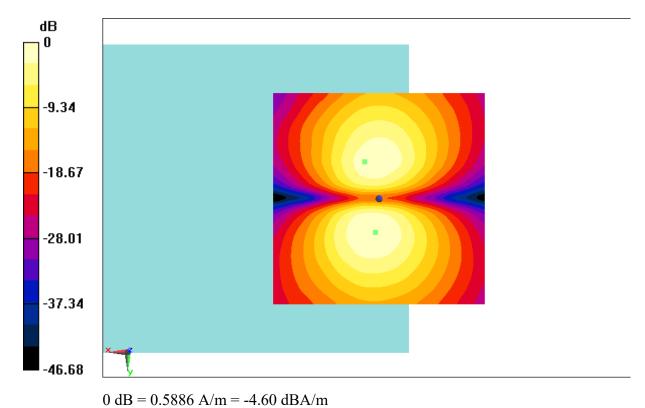


Fig B.11 T-Coil LTE B5



T-Coil LTE B5 10M Perpendicular

Date: 2018-4-21

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.5°C

Communication System: LTE B5; Frequency: 836.5 MHz; Duty Cycle: 1:1

Probe: AM1DV2 - 1064;

T-Coil/General Scans/z (axial) 4.2mm 50 x 50 10M/ABM Interpolated

Signal(x,y,z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1 = 3.56 dBA/m BWC Factor = 0.16 dB Location: 3.3, -0.8, 3.7 mm

T-Coil/General Scans/z (axial) 4.2mm 50 x 50 10M/ABM Interpolated

SNR(x,y,z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

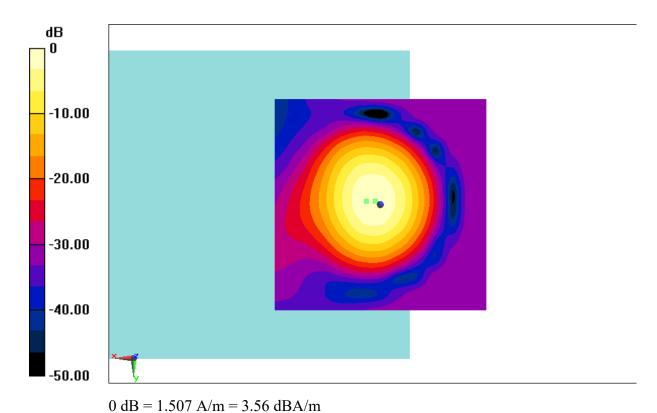
BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1/ABM2 = 53.01 dB ABM1 comp = 3.16 dBA/m BWC Factor = 0.16 dB Location: 1.3, -0.8, 3.7 mm





1.507 TUIN 5.50 CD TUIN

Fig B.12 T-Coil LTE B5



T-Coil LTE B12 1.4M Transverse

Date: 2018-4-21

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.5°C

Communication System: LTE B7; Frequency: 2535 MHz; Duty Cycle: 1:1

Probe: AM1DV2 - 1064;

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50 1.4M/ABM Interpolated

Signal(x,y,z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1 = -4.52 dBA/m BWC Factor = 0.16 dB Location: 2.5, -8.8, 3.7 mm

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50 1.4M/ABM Interpolated SNR(x,y,z)

(121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

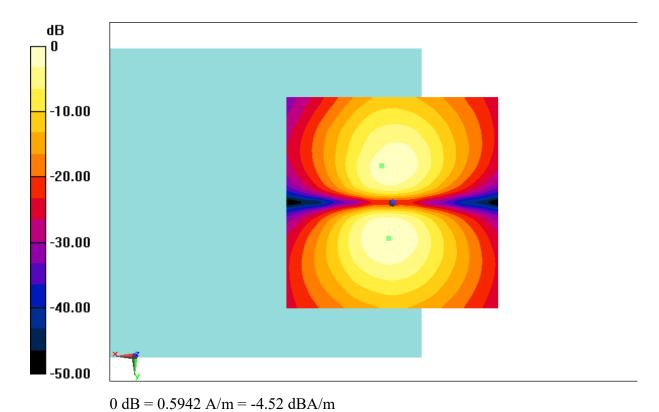
Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1/ABM2 = 48.06 dB ABM1 comp = -4.72 dBA/m BWC Factor = 0.16 dB

Location: 0.8, 8.3, 3.7 mm





-- -----

Fig B.13 T-Coil LTE B12



T-Coil LTE B12 1.4M Perpendicular

Date: 2018-4-21

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.5°C

Communication System: LTE B7; Frequency: 2535 MHz; Duty Cycle: 1:1

Probe: AM1DV2 - 1064;

T-Coil/General Scans/z (axial) 4.2mm 50 x 50 1.4M/ABM Interpolated Signal(x,y,z)

(121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1 = 3.78 dBA/m BWC Factor = 0.16 dB Location: 2.5, -0.4, 3.7 mm

T-Coil/General Scans/z (axial) 4.2mm 50 x 50 1.4M/ABM Interpolated SNR(x,y,z)

(121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1/ABM2 = 53.64 dB ABM1 comp = 3.37 dBA/m BWC Factor = 0.16 dB Location: 0.4, -0.4, 3.7 mm



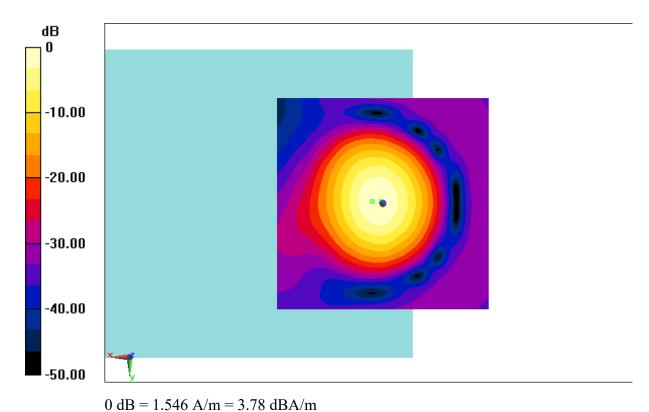


Fig B.14 T-Coil LTE B12



T-Coil LTE B12 3M Transverse

Date: 2018-4-21

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.5°C

Communication System: LTE B7; Frequency: 2535 MHz; Duty Cycle: 1:1

Probe: AM1DV2 - 1064;

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50 3M/ABM Interpolated

Signal(x,y,z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1 = -4.05 dBA/m BWC Factor = 0.16 dB Location: 3.3, -8.8, 3.7 mm

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50 3M/ABM Interpolated

SNR(x,y,z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

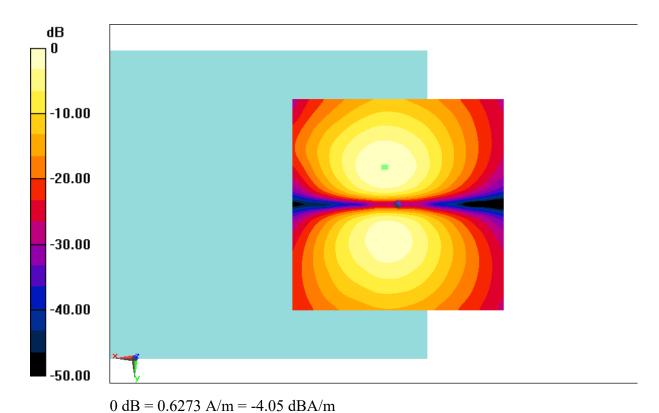
ABM1/ABM2 = 48.70 dB

ABM1 comp = -4.07 dBA/m

BWC Factor = 0.16 dB

Location: 2.9, -8.8, 3.7 mm





4.03 db/t/li

Fig B.15 T-Coil LTE B12



T-Coil LTE B12 3M Perpendicular

Date: 2018-4-21

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.5°C

Communication System: LTE B7; Frequency: 2535 MHz; Duty Cycle: 1:1

Probe: AM1DV2 - 1064;

T-Coil/General Scans/z (axial) 4.2mm 50 x 50 3M/ABM Interpolated Signal(x,y,z)

(121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1 = -2.63 dBA/m BWC Factor = 0.16 dB Location: 3.3, -0.4, 3.7 mm

T-Coil/General Scans/z (axial) 4.2mm 50 x 50 3M/ABM Interpolated SNR(x,y,z)

(121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

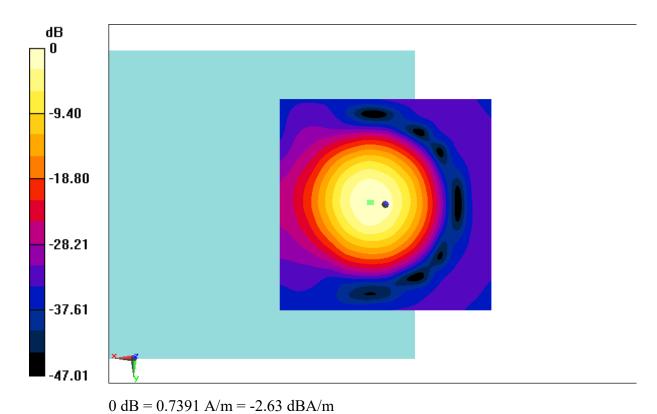
Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1/ABM2 = 48.24 dB ABM1 comp = -2.64 dBA/mBWC Factor = 0.16 dB

Location: 3.8, -0.4, 3.7 mm





0.7371 7VIII 2.03 dB/VII

Fig B.16 T-Coil LTE B12



T-Coil LTE B14 10M Transverse

Date: 2018-4-22

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.5°C

Communication System: LTE B12; Frequency: 707.5 MHz; Duty Cycle: 1:1

Probe: AM1DV2 - 1064;

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50 10M/ABM Interpolated

Signal(x,y,z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1 = -4.02 dBA/m BWC Factor = 0.16 dB Location: 3.3, -8.8, 3.7 mm

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50 10M/ABM Interpolated

SNR(x,y,z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

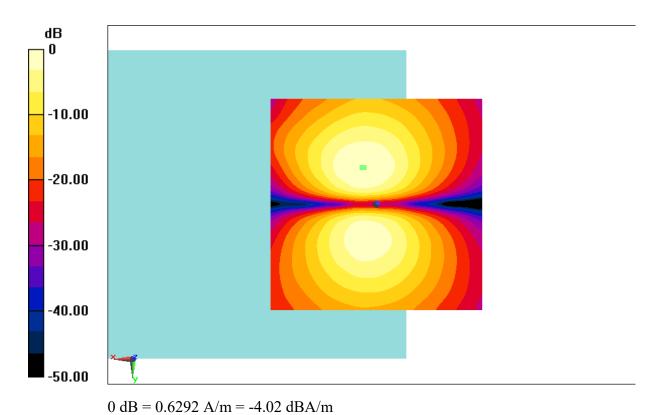
ABM1/ABM2 = 48.81 dB

ABM1 comp = -4.05 dBA/m

BWC Factor = 0.16 dB

Location: 2.9, -8.8, 3.7 mm





4.02 dB/VII

Fig B.17 T-Coil LTE B14



T-Coil LTE B14 10M Perpendicular

Date: 2018-4-22

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.5°C

Communication System: LTE B12; Frequency: 707.5 MHz; Duty Cycle: 1:1

Probe: AM1DV2 - 1064;

T-Coil/General Scans/z (axial) 4.2mm 50 x 50 10M/ABM Interpolated

Signal(x,y,z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1 = 4.20 dBA/m BWC Factor = 0.16 dB Location: 3.3, -0.4, 3.7 mm

T-Coil/General Scans/z (axial) 4.2mm 50 x 50 10M/ABM Interpolated

SNR(x,y,z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1/ABM2 = 54.60 dB ABM1 comp = 4.20 dBA/m BWC Factor = 0.16 dB Location: 3.3, -0.4, 3.7 mm



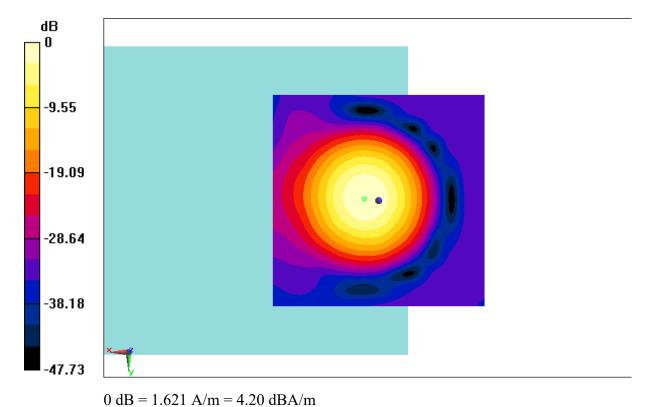


Fig B.18 T-Coil LTE B14



T-Coil LTE B30 5M Transverse

Date: 2018-4-22

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.5°C

Communication System: LTE B13; Frequency: 782 MHz; Duty Cycle: 1:1

Probe: AM1DV2 - 1064;

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50 5M/ABM Interpolated

Signal(x,y,z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1 = -4.03 dBA/m BWC Factor = 0.16 dB Location: 3.3, -8.3, 3.7 mm

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50 5M/ABM Interpolated

SNR(x,y,z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1/ABM2 = 49.17 dB ABM1 comp = -4.05 dBA/m BWC Factor = 0.16 dB

Location: 2.9, -8.8, 3.7 mm



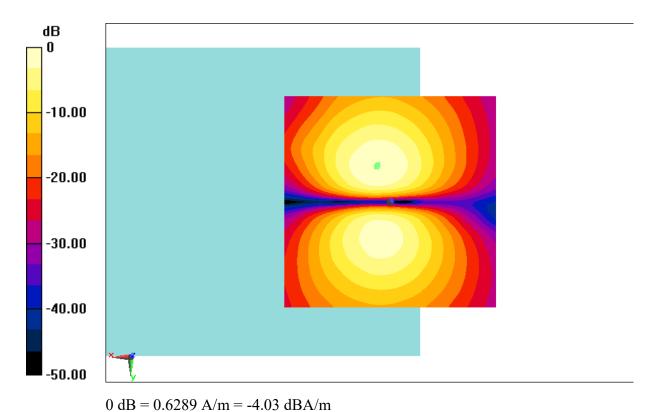


Fig B.19 T-Coil LTE B30



T-Coil LTE B30 5M Perpendicular

Date: 2018-4-22

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.5°C

Communication System: LTE B13; Frequency: 782 MHz; Duty Cycle: 1:1

Probe: AM1DV2 - 1064;

T-Coil/General Scans/z (axial) 4.2mm 50 x 50 5M/ABM Interpolated

Signal(x,y,z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1 = 4.17 dBA/m BWC Factor = 0.16 dB Location: 3.3, -0.4, 3.7 mm

T-Coil/General Scans/z (axial) 4.2mm 50 x 50 5M/ABM Interpolated

SNR(x,y,z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

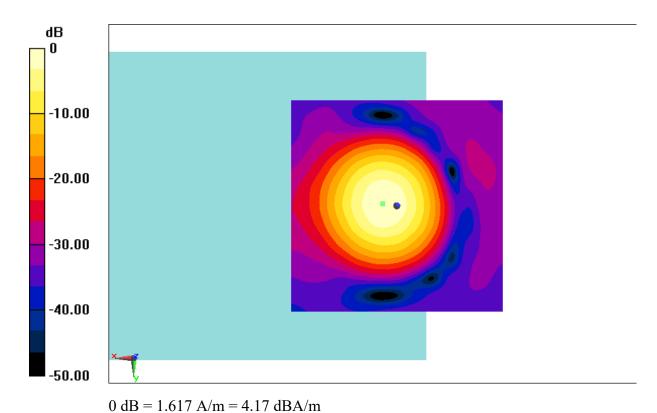
BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1/ABM2 = 54.33 dB ABM1 comp = 4.17 dBA/m BWC Factor = 0.16 dB Location: 3.3, -0.4, 3.7 mm





7 CD 1:01/10 HI 4:1/ CD/10 H

Fig B.20 T-Coil LTE B30



T-Coil LTE B30 10M Transverse

Date: 2018-4-22

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.5°C

Communication System: LTE B13; Frequency: 782 MHz; Duty Cycle: 1:1

Probe: AM1DV2 - 1064;

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50 10M/ABM Interpolated

Signal(x,y,z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1 = -4.00 dBA/m BWC Factor = 0.16 dB Location: 3.8, -8.3, 3.7 mm

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50 10M/ABM Interpolated

SNR(x,y,z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1/ABM2 = 49.17 dB

ABM1 comp = -4.08 dBA/m

BWC Factor = 0.16 dB Location: 2.9, -8.8, 3.7 mm



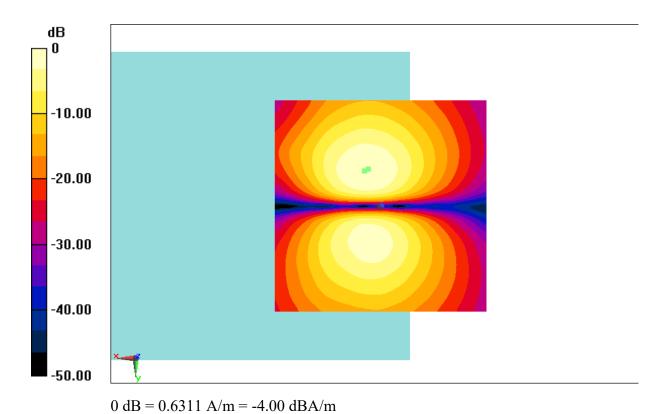


Fig B.21 T-Coil LTE B30



T-Coil LTE B30 10M Perpendicular

Date: 2018-4-22

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.5°C

Communication System: LTE B13; Frequency: 782 MHz; Duty Cycle: 1:1

Probe: AM1DV2 - 1064;

T-Coil/General Scans/z (axial) 4.2mm 50 x 50 10M/ABM Interpolated

Signal(x,y,z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1 = 4.28 dBA/m BWC Factor = 0.16 dB Location: 3.8, -0.4, 3.7 mm

T-Coil/General Scans/z (axial) 4.2mm 50 x 50 10M/ABM Interpolated

SNR(x,y,z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

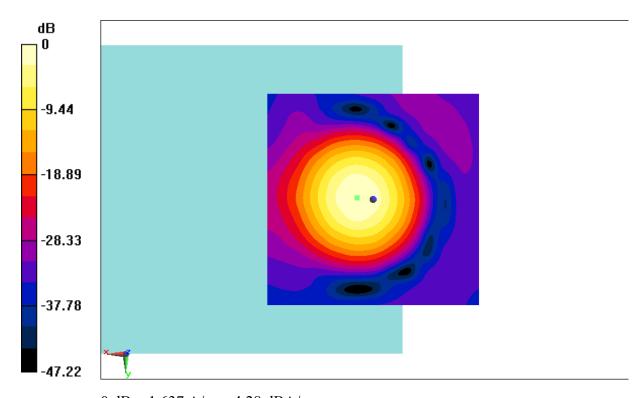
BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1/ABM2 = 54.52 dB ABM1 comp = 4.28 dBA/m BWC Factor = 0.16 dB Location: 3.8, -0.4, 3.7 mm





0 dB = 1.637 A/m = 4.28 dBA/m

Fig B.22 T-Coil LTE B30



T-Coil LTE B66 1.4M Transverse

Date: 2018-4-23

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.5°C

Communication System: LTE B66; Frequency: 1745 MHz; Duty Cycle: 1:1

Probe: AM1DV2 - 1064;

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50 1.4M/ABM Interpolated

Signal(x,y,z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1 = -4.21 dBA/m BWC Factor = 0.16 dB Location: 3.3, -8.8, 3.7 mm

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50 1.4M/ABM Interpolated

SNR(x,y,z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

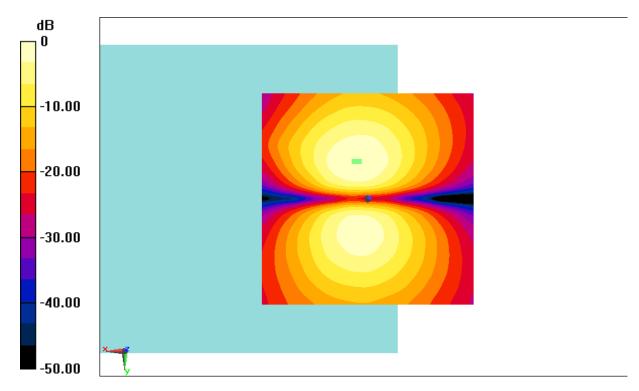
ABM1/ABM2 = 50.21 dB

ABM1 comp = -4.29 dBA/m

BWC Factor = 0.16 dB

Location: 2.1, -8.8, 3.7 mm





0 dB = 0.6157 A/m = -4.21 dBA/m

Fig B.23 T-Coil LTE B66



T-Coil LTE B66 1.4M Perpendicular

Date: 2018-4-23

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.5°C

Communication System: LTE B66; Frequency: 1745 MHz; Duty Cycle: 1:1

Probe: AM1DV2 - 1064;

T-Coil/General Scans/z (axial) 4.2mm 50 x 50 1.4M/ABM Interpolated

Signal(x,y,z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1 = 3.55 dBA/m BWC Factor = 0.16 dB Location: 3.3, -0.8, 3.7 mm

T-Coil/General Scans/z (axial) 4.2mm 50 x 50 1.4M/ABM Interpolated

SNR(x,y,z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1/ABM2 = 53.60 dB ABM1 comp = 3.02 dBA/m BWC Factor = 0.16 dB Location: 0.8, -0.4, 3.7 mm



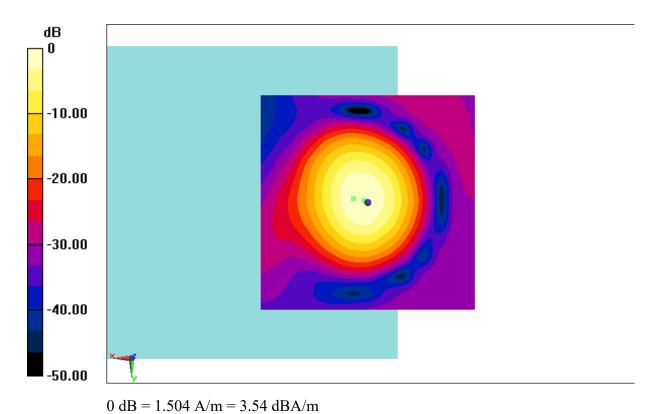


Fig B.24 T-Coil LTE B66



T-Coil LTE B66 15M Transverse

Date: 2018-4-23

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.5°C

Communication System: LTE B66; Frequency: 1745 MHz; Duty Cycle: 1:1

Probe: AM1DV2 - 1064;

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50 15M/ABM Interpolated

Signal(x,y,z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1 = -4.30 dBA/m BWC Factor = 0.16 dB Location: 3.8, -8.8, 3.7 mm

T-Coil/General Scans/y (transversal) 4.2mm 50 x 50 15M/ABM Interpolated

SNR(x,y,z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1/ABM2 = 48.30 dB ABM1 comp = -4.92 dBA/m BWC Factor = 0.16 dB

Location: 0.8, 8.3, 3.7 mm



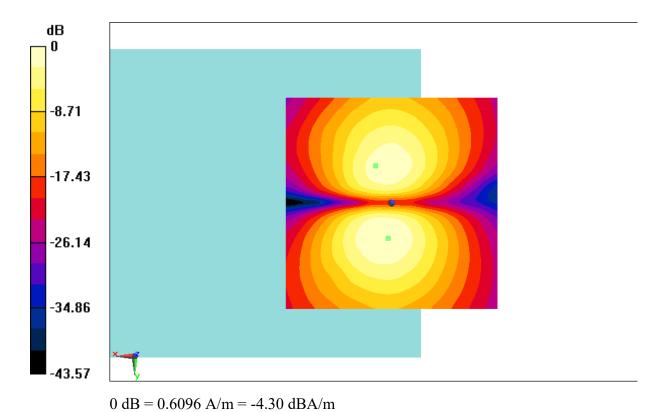


Fig B.25 T-Coil LTE B66



T-Coil LTE B66 15M Perpendicular

Date: 2018-4-23

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.5°C

Communication System: LTE B66; Frequency: 1745 MHz; Duty Cycle: 1:1

Probe: AM1DV2 - 1064;

T-Coil/General Scans/z (axial) 4.2mm 50 x 50 15M/ABM Interpolated

Signal(x,y,z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1 = 4.09 dBA/m BWC Factor = 0.16 dB Location: 3.3, -0.4, 3.7 mm

T-Coil/General Scans/z (axial) 4.2mm 50 x 50 15M/ABM Interpolated

SNR(x,y,z) (121x121x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm

Signal Type: Audio File (.wav) 48k voice 1kHz 1s.wav

Output Gain: 100

Measure Window Start: 300ms Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

Cursor:

ABM1/ABM2 = 53.65 dB ABM1 comp = 3.54 dBA/m BWC Factor = 0.16 dB Location: 1.3, -0.4, 3.7 mm



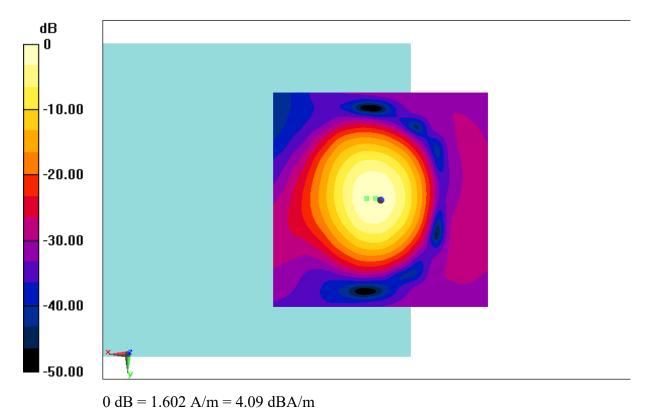


Fig B.26 T-Coil LTE B66



ANNEX C FREQUENCY REPONSE CURVES

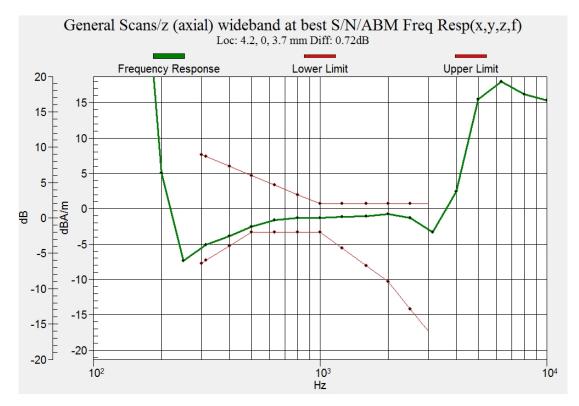


Figure C.1 Frequency Response of WCDMA 850

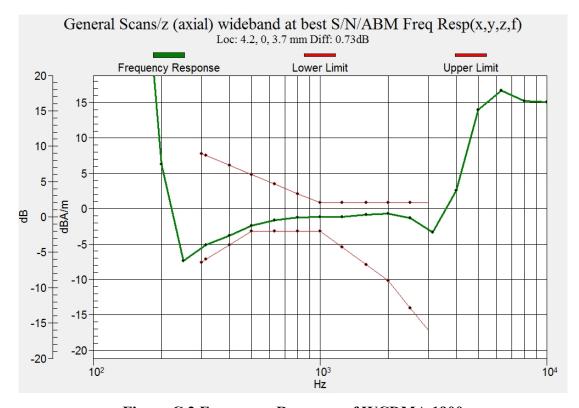


Figure C.2 Frequency Response of WCDMA 1900



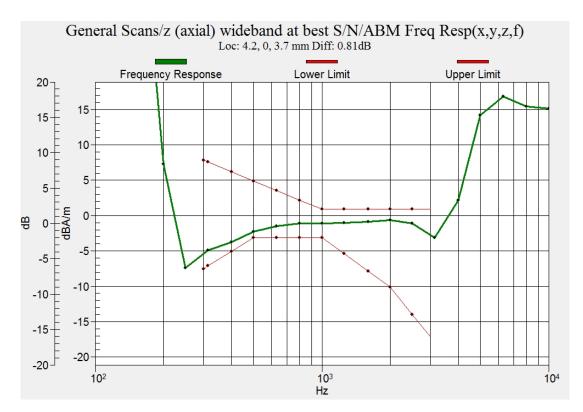


Figure C.3 Frequency Response of WCDMA 1700

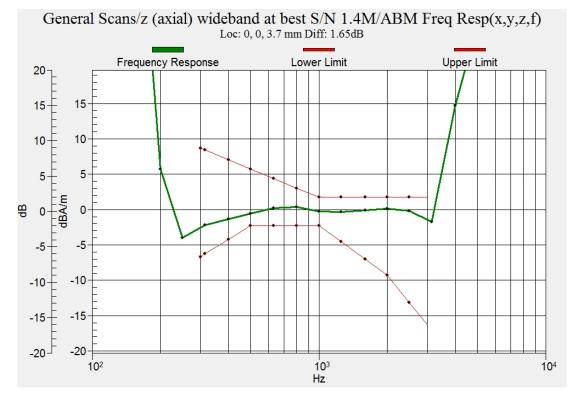


Figure C.4 Frequency Response of LTE B2 1.4M



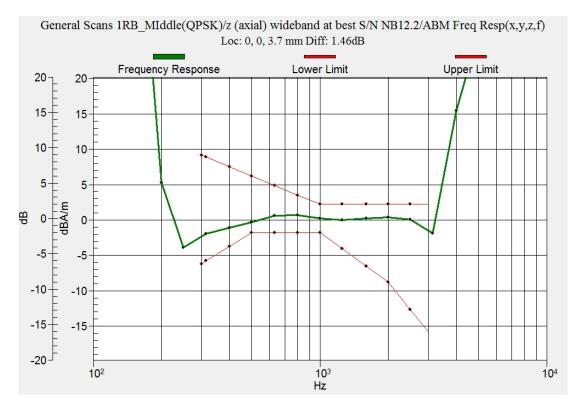


Figure C.5 Frequency Response of LTE B2 20M

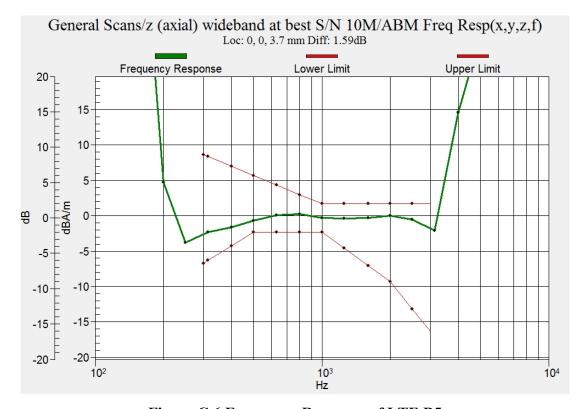


Figure C.6 Frequency Response of LTE B5



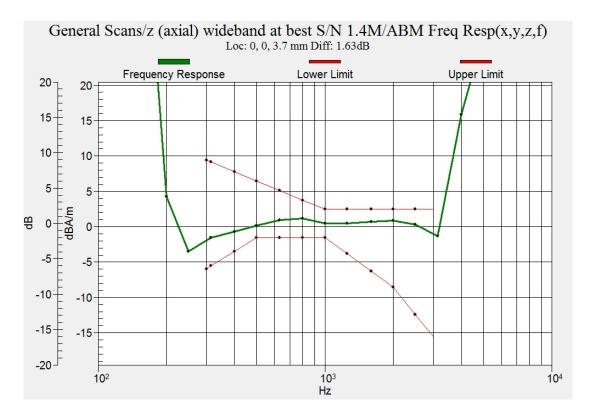


Figure C.7 Frequency Response of LTE B12 1.4M

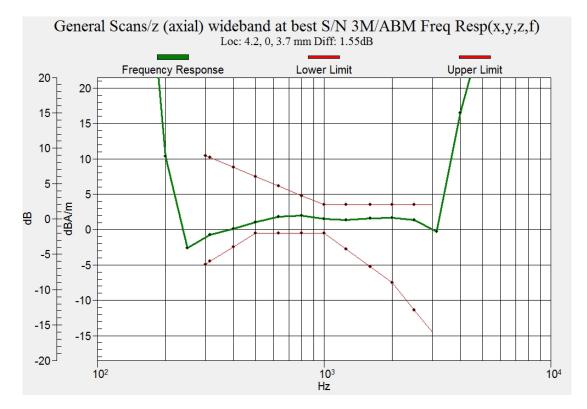


Figure C.8 Frequency Response of LTE B12 3M



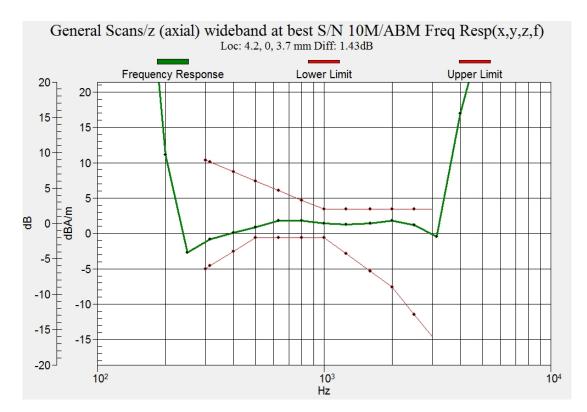


Figure C.9 Frequency Response of LTE B14

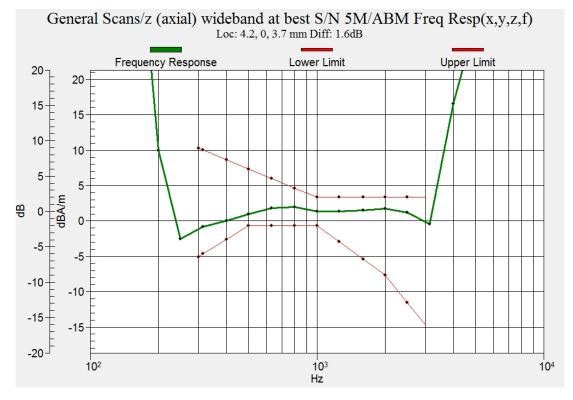


Figure C.10 Frequency Response of LTE B30 5M



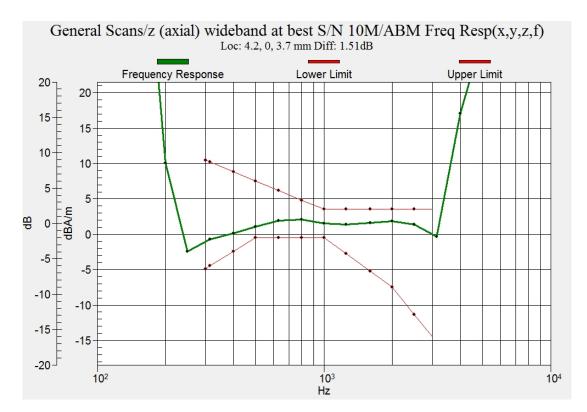


Figure C.11 Frequency Response of LTE B30 10M



Figure C.12 Frequency Response of LTE B66 1.4M



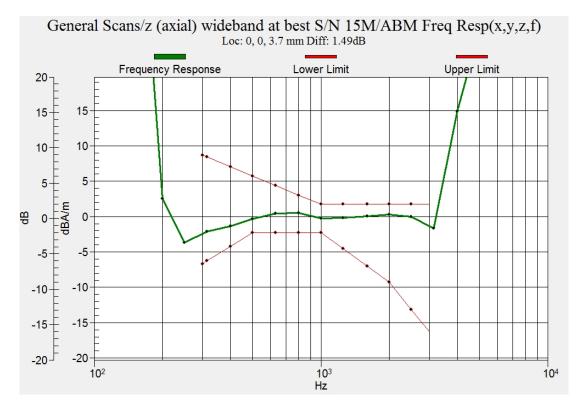


Figure C.13 Frequency Response of LTE B66 15M



ANNEX D PROBE CALIBRATION CERTIFICATE

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
Servizio svizzero di taratura

S Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Client CTTL-BJ (Auden) Certificate No: AM1DV2-1064_Jul17 **CALIBRATION CERTIFICATE** Object AM1DV2 - SN: 1064 Calibration procedure(s) QA CAL-24.v4 Calibration procedure for AM1D magnetic field probes and TMFS in the audio range Calibration date: July 20, 2017 This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate. All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) Primary Standards ID# Cal Date (Certificate No.) Scheduled Calibration Keithley Multimeter Type 2001 SN: 0810278 09-Sep-16 (No. 19065) Sep-17 Reference Probe AM1DV2 SN: 1008 30-Dec-16 (No. AM1D-1008 Dec16) Dec-17 DAE4 SN: 781 13-Jul-17 (No. DAE4-781_Jul17) Jul-18 ID# Secondary Standards Check Date (in house) Scheduled Check AMCC SN: 1050 01-Oct-13 (in house check Sep-15) Oct-17 AMMI Audio Measuring Instrument | SN: 1062 26-Sep-12 (in house check Sep-15) Oct-17 Name Function Calibrated by: Claudio Leubler Laboratory Technician Katja Pokovic Technical Manager Approved by: Issued: July 20, 2017 This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: AM1DV2-1064_Jul17



[References

- [1] ANSI-C63.19-2007 American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.
- [2] ANSI-C63.19-2011 American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.
- [3] DASY5 manual, Chapter: Hearing Aid Compatibility (HAC) T-Coil Extension

Description of the AM1D probe

The AM1D Audio Magnetic Field Probe is a fully shielded magnetic field probe for the frequency range from 100 Hz to 20 kHz. The pickup coil is compliant with the dimensional requirements of [1+2]. The probe includes a symmetric low noise amplifier for the signal available at the shielded 3 pin connector at the side. Power is supplied via the same connector (phantom power supply) and monitored via the LED near the connector. The 7 pin connector at the end of the probe does not carry any signals, but determines the angle of the sensor when mounted on the DAE. The probe supports mechanical detection of the surface.

probe supports mechanical detection of the surface.

The single sensor in the probe is arranged in a tilt angle allowing measurement of 3 orthogonal field components when rotating the probe by 120° around its axis. It is aligned with the perpendicular component of the field, if the probe axis is tilted nominally 35.3° above the measurement plane, using the connector rotation and sensor angle stated below.

The probe is fully RF shielded when operated with the matching signal cable (shielded) and allows measurement of audio magnetic fields in the close vicinity of RF emitting wireless devices according to [1+2] without additional shielding.

Handling of the item

The probe is manufactured from stainless steel. In order to maintain the performance and calibration of the probe, it must not be opened. The probe is designed for operation in air and shall not be exposed to humidity or liquids. For proper operation of the surface detection and emergency stop functions in a DASY system, the probe must be operated with the special probe cup provided (larger diameter).

Methods Applied and Interpretation of Parameters

- Coordinate System: The AM1D probe is mounted in the DASY system for operation with a HAC
 Test Arch phantom with AMCC Helmholtz calibration coil according to [3], with the tip pointing to
 "southwest" orientation.
- Functional Test: The functional test preceding calibration includes test of Noise level
 RF immunity (1kHz AM modulated signal). The shield of the probe cable must be well connected.
 Frequency response verification from 100 Hz to 10 kHz.
- Connector Rotation: The connector at the end of the probe does not carry any signals and is used for fixation to the DAE only. The probe is operated in the center of the AMCC Helmholtz coil using a 1 kHz magnetic field signal. Its angle is determined from the two minima at nominally +120° and 120° rotation, so the sensor in the tip of the probe is aligned to the vertical plane in z-direction, corresponding to the field maximum in the AMCC Helmholtz calibration coil.
- Sensor Angle: The sensor tilting in the vertical plane from the ideal vertical direction is determined from the two minima at nominally +120° and -120°. DASY system uses this angle to align the sensor for radial measurements to the x and y axis in the horizontal plane.

Sensitivity: With the probe sensor aligned to the z-field in the AMCC, the output of the probe is compared to the magnetic field in the AMCC at 1 kHz. The field in the AMCC Helmholtz coil is given by the geometry and the current through the coil, which is monitored on the precision shunt resistor of the coil.

Certificate No: AM1DV2-1064_Jul17



AM1D probe identification and configuration data

Item	AM1DV2 Audio Magnetic 1D Field Probe		
Type No	SP AM1 001 AF		
Serial No	1064		

Overall length	296 mm
Tip diameter	6.0 mm (at the tip)
Sensor offset	3.0 mm (centre of sensor from tip)
Internal Amplifier	40 dB

Manufacturer / Origin	Schmid & Partner Engineering AG, Zurich, Switzerland
Manufacturing date	November 06, 2007
Last calibration date	July 22, 2016

Calibration data

Connector rotation angle	(in DASY system)	104.1 °	+/- 3.6 ° (k=2)
Sensor angle	(in DASY system)	0.44 °	+/- 0.5 ° (k=2)

Sensitivity at 1 kHz (in DASY system) **0.0657 V / (A/m)** +/- 2.2 % (k=2)

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.



ANNEX E DAE CALIBRATION CERTIFICATE

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





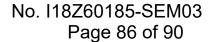
Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura **Swiss Calibration Service**

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 0108

Client CTTL (Auden)		Certificate No:	DAE4-777_Sep17
CALIBRATION C	ERTIFICATE		
Object	DAE4 - SD 000 D	04 BM - SN: 777	
Calibration procedure(s)	QA CAL-06.v29 Calibration proced	dure for the data acquisition elect	ronics (DAE)
Calibration date:	September 08, 20	17	
The measurements and the unce All calibrations have been conduct Calibration Equipment used (M&T	rtainties with confidence protected in the closed laboratory TE critical for calibration)	onal standards, which realize the physical unit obability are given on the following pages and σ facility: environment temperature (22 \pm 3)°C	are part of the certificate.
Primary Standards Keithley Multimeter Type 2001	ID # SN: 0810278	Cal Date (Certificate No.)	Scheduled Calibration
Secondary Standards	ID#	31-Aug-17 (No:21092) Check Date (in house)	Aug-18 Scheduled Check
Auto DAE Calibration Unit Calibrator Box V2.1		05-Jan-17 (in house check) 05-Jan-17 (in house check)	In house check: Jan-18 In house check: Jan-18
Calibrated by:	Name Dominique Steffen	Function Laboratory Technician	Signature
			Set 1
Approved by:	Sven Kühn	Deputy Manager	W. B. OLLIN
			4 0000

Certificate No: DAE4-777_Sep17 Page 1 of 5





Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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S Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA

Multilateral Agreement for the recognition of calibration certificates

Glossary

DAE Connector angle data acquisition electronics

information used in DASY system to align probe sensor X to the robot

coordinate system.

Methods Applied and Interpretation of Parameters

 DC Voltage Measurement: Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.

- Connector angle: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - DC Voltage Measurement Linearity: Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - Common mode sensitivity: Influence of a positive or negative common mode voltage on the differential measurement.
 - Channel separation: Influence of a voltage on the neighbor channels not subject to an input voltage.
 - AD Converter Values with inputs shorted: Values on the internal AD converter corresponding to zero input voltage
 - Input Offset Measurement: Output voltage and statistical results over a large number of zero voltage measurements.
 - Input Offset Current: Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - Input resistance: Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - Low Battery Alarm Voltage: Typical value for information. Below this voltage, a battery alarm signal is generated.
 - Power consumption: Typical value for information. Supply currents in various operating modes.

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DC Voltage Measurement
A/D - Converter Resolution nominal
High Range: 1LSB = $6.1 \mu V$, full range = -100...+300 mV full range = -1......+3mV Low Range: 1LSB = 61nV, DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	х	Υ	z
High Range	405.400 ± 0.02% (k=2)	405.869 ± 0.02% (k=2)	405.579 ± 0.02% (k=2)
Low Range	3.96640 ± 1.50% (k=2)	3.96264 ± 1.50% (k=2)	4.00499 ± 1.50% (k=2)

Connector Angle

Connector Angle to be used in DASY system	97.0°±1°
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Certificate No: DAE4-777_Sep17



Appendix (Additional assessments outside the scope of SCS0108)

1. DC Voltage Linearity

High Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	200022.73	-12.42	-0.01
Channel X + Input	20003.49	-1.25	-0.01
Channel X - Input	-19998.82	6.77	-0.03
Channel Y + Input	200025.10	-10.04	-0.01
Channel Y + Input	20007.22	2.54	0.01
Channel Y - Input	-20002.34	3.30	-0.02
Channel Z + Input	200028.10	-6.82	-0.00
Channel Z + Input	20002.36	-2.19	-0.01
Channel Z - Input	-20003.64	2.12	-0.01

Low Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	2000.54	-0.37	-0.02
Channel X + Input	201.37	0.50	0.25
Channel X - Input	-199.19	-0.20	0.10
Channel Y + Input	1999.95	-0.89	-0.04
Channel Y + Input	200.04	-0.75	-0.37
Channel Y - Input	-199.96	-0.85	0.43
Channel Z + Input	2001.05	0.20	0.01
Channel Z + Input	199.88	-0.86	-0.43
Channel Z - Input	-200.02	-0.88	0.44

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	5.45	3.79
	- 200	3.93	0.83
Channel Y	200	7.70	7.39
	- 200	-9.52	-8.90
Channel Z	200	7.51	6.49
	- 200	-9.21	-8.71

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (µV)	Channel Z (μV)
Channel X	200	-	-1.61	-2.84
Channel Y	200	8.30		0.46
Channel Z	200	6.69	5.02	-

Certificate No: DAE4-777_Sep17



4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15919	14652
Channel Y	16343	14477
Channel Z	16033	14911

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 seo; Measuring time: 3 sec

Input 10MΩ

	Average (μV)	min. Offset (μV)	max. Offset (μV)	Std. Deviation (µV)
Channel X	-0.50	-2.04	0.95	0.51
Channel Y	1.56	0.40	2.80	0.48
Channel Z	0.26	-0.78	1.16	0.42

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)	
Supply (+ Vcc)	+7.9	
Supply (- Vcc)	-7.6	

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9



The photos of HAC test are presented in the additional document:

Appendix to test report no. I18Z60185-SEM02/03

The photos of HAC test